

# NATIONAL INSTITUTE OF TECHNOLOGY

TIRUCHIRAPPALLI - 620 015, TAMIL NADU, INDIA

UUI	URSE PL	.AN (PAR	T(I)					
B. 7	B. Tech Electrical & Electronics Engineering							
Ele	Electron Device							
EEI	EEPC13			of Credits		3		
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Jul	July 2025			tion (if, app	licable)	Α		
Dr.	Dr. Ankur Singh Rana			artment		EEE		
ank	ankur@nitt.edu			phone No.		9910478111		
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IR	Core			Open Elective	Minor	Honours	Laboratory	
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COURSE CONTENT (as in latest curriculum)

Semi-conductors - charge carriers, electrons and holes in intrinsic and extrinsic semiconductors -Hall effect.

Diodes – PN junction – current equation – Junction Capacitance – breakdown characteristics of Zener diode, Tunnel diode, Schottky diode.

Bipolar junction transistors - Characteristics - Analysis of CB, CE, CC amplifier configurations.

Unipolar devices – FET, MOSFET, UJT and Opto-Electronic devices – theory and characteristics.

Rectifiers and switched mode power supplies - theory and design, filter circuits, applications.

#### References

- 1. David, A. Bell, 'Electronic Devices and Circuits', PHI, 5th Edition, 2008
- 2. Millman and Halkias 'Electronic Devices and Circuits', McGraw Hill International Student, 2nd Edition, 2007.
- 3. Robert L. Boylestad and Louis Nashelsky, 'Electronic Devices and Circuit Theory', Pearson Prentice Hall, 10th Edition, 2009.
- 4. Thomas L. Floyd, 'Electronic Devices', Pearson Education Limited, 9th Edition, 2013.
- 5. Allen Mottershead, 'Electronic Devices and Circuits An Introduction', PHI, 18th Reprint, 2010.
- 6. Albert Malvino and David J Bates, 'Electronic Principles', McGraw Hill, 7th Edition, 2007.

### COURSE LEARING OBJECTIVES

To educate on the construction and working of common electronic devices and to prepare for application areas.

62721	COURSE OUTCOMES (CO)													
	Course Outcomes	Align	red P	rogr	amme	Outo	come	s (PO	(Ass	ign lev	/el – 1 (	or 2 or	3 or b	lank)
After successful completion of the course, the students should be able to:			1	2	3	4	5	6	7	8	9	10	11	12
		CO1	2	2	1	1	1	2	1	2	3	2	1	2
			3	3	2	2	2	1	1	2	3	2	1	2
CO1	CO1 Understand the semiconductor physics of the intrinsic, p and n	CO3	3	3	2	2	2	1	1	2	3	2	1	2
		CO4	3	3	3	2	3	1	1_1_	2	3	3	1	2
	materials and various devices	CO5	2	2	11	1_	1_	2	1	2	3	2	1	2
	and characteristics.													
CO2	Analyze simple diode circuits													
	under DC and AC excitation.													
CO3	Analyze and design simple													
	amplifier circuits using BJT in													
	CE, CC and CB configurations													
CO4	Understand the analysis and													
	salient features of CE, CC & CB	-												
	amplifier circuits													
CO5		-												
	characteristics of FET, MOSFET													
	and UJT.													

## COURSE PLAN (PART II) COURSE OVERVIEW

The basic understanding of electronics devices is established by studying the semiconductor material like p-type and n-type material. After knowing the material, PN junction semiconductor devices will be discussed which is necessary to understand the construction of devices like diode, BJT, FET. Operation of these devices along with its input and output characteristics will be discussed. After understanding the devices, some of its applications like rectifiers, switched mode power supplies, filter circuit etc. will be discussed

SI.		<b>COURSE TEA</b>	CHING A	ND LEARNING ACTIVITIES				
No.		Topic						
1.	(Week 1)		Introdu	action to the course, Semiconductor	Mode of Deliver			
2.	07.07.25 to 11.07.25 (3	Contact hours)	madaa	istion to the course, Semiconductor	PPT/Chalk & Talk			
2.	(Week 2) 14.07.25 to 18.07.25 (3		Charge		PPT/Chalk & Talk			
3.	(Week 3)			nductors				
	21.07.25 to 25.07.25 (3 (	Contact hours)	effect	ortation of carrier: Drift and diffusion, Hall	PPT/Chalk & Talk			
4.	(Week 4)			Junction, Current equation diode,	PPT/Chalk & Talk			
5.	28.07.25 to 01.08.25 (3 (Week 5)	Contact hours)	charact	teristics	FF1/Chaik & Talk			
	04.08.25 to 08.08.25 (3 (	Contact hours)	Small s	ignal model of diode, junction capacitance	PPT/Chalk & Talk			
6.	(Week 6)		Zener (	diode: breakdown characteristics, tunnel	557101			
7.	11.08.25 to 15.08.25 (2 (	Contact hours)	diode, S	Schottky diode, Application of diode	PPT/Chalk & Talk			
1.	(Week 7)		Introduc	ction to BJT, types of BJT. Its operation	PPT/Chalk & Talk			
8.	18.08.25 to 22.08.25 (3 (Week 8)	contact hours)	and cha	aracteristics	THE TOTAL A TAIK			
	25.08.25 to 29.08.25 (1 C	Contact hours)	configu	Analysis of CB, CE, CC amplifier	PPT/Chalk & Talk			
9.	(Week 9)		Introduc	ction to FET, MOSFET.	DDT/Challe 9 Tall			
10.	01.09.25 to 05.09.25 (2 C	contact hours)			PPT/Chalk & Talk			
10.	(Week 10) 08.09.25 to 12.09.25 (3 C	Ontact hours)	Constru	ction Operation of MOSFET and its	PPT/Chalk & Talk			
11.	(Week 11)		Characte	eristics ectronic devices – theory and characteristics				
40	15.09.25 to 19.09.25 (2 C	ontact hours)	Opio Lie	celloring devices – theory and characteristics	PPT/Chalk & Talk			
12.	(Week 12)		Rectifier	s and switched mode power supplies	PPT/Chalk & Talk			
13.	22.09.25 to 26.09.25 (3 C (Week 13)	ontact nours)			4 10			
	29.09.25 to 03.10.25 (2 C	ontact hours)	and desi	s and switched mode power supplies theory	PPT/Chalk & Talk			
14.	(Week 14)		Filter circ	cuits, Rectifiers applications	PPT/Chalk & Talk			
15.	06.10.25 to 10.10.25 (3 C	ontact hours)			Triffchaik & Talk			
10.	(Week 15) 13.10.25 to 17.10.25 (3 Co	ontact hours)	Rectifier	applications	PPT/Chalk & Talk			
16.	(Week 16)		Rectifier	applications	DDT/O:			
47	20.10.25 to 24.10.25 (3 Cd	ontact hours)			PPT/Chalk & Talk			
17.	(Week 17)			PPT/Chalk & Talk				
Contract Name	27.10.25 to 28.10.25 (0 Cd		ACCECO	MENT METHODS				
SI.	Mode of Assessment	Week / [		A TOTAL CONTROL OF THE PROPERTY OF THE PROPERT				
No.	A THE RESIDENCE OF THE SECOND		14 14 15	Duration	% Weightage			
1.	Class test -1	(Week		60 minutes	15 %			
2.	Class test -2	18.08.25 to 2 (Week			10 70			
	3,433,1031, 2	13.10.25 to 1		60 minutes	15 %			
3.	Assignment	Throughout Se		Assignment: solutions for the	5 + 15 = 20%			
	Surprise Quiz			questions (from first class to last class )	3 + 15 = 20%			
				need to be submitted in week 16				
				Surprise quiz : Out of N, (N-1) will be considered for evaluation of marks				
204	1			Note: No compensation for surprise quiz	,			
CPA	Compensation	(Week 1		60 minutes	15%			
	Assessment	27.10.25 to 2	8.10.25		1070			
4.	Final Assessment	As per inst	itute	180 minutes				
9		schedul		180 minutes	50%			
	2.1							
7 1					1			

### COURSE EXIT SURVEY (mention the ways in which the feedback about the course is assessed and indicate the attainment also)

- Feedback from the students during class committee meetings
- Anonymous feedback through questionnaire (Mid of the semester & End of the semester)
- End semester feedback on course outcomes

#### COMPENSATION POLICY

- Only one instance of absence is acceptable in continuous assessment, and a compensation assessment for such cases will be conducted only once.
- Compensation assessments are restricted to genuine reasons, like severe illness, and require valid proof in the form of a medical certificate issued by the NITT hospital medical officer.
- In situations where students anticipate missing assessments due to unavoidable reasons, prior intimation to
  the faculty is essential. If a student is unable to provide advance notice due to sudden illness or emergencies,
  they must communicate the reason and submit valid proof of the absence within one week of the assessment.

### ATTENDANCE POLICY

- At least 75% attendance in each course is mandatory.
- A maximum of 10% shall be allowed under On Duty (OD) category.
- Students with less than 65% of attendance shall be prevented from writing the final assessment and shall be awarded 'V' grade. Students awarded 'V' grade must compulsorily redo the course.

### ACADEMIC DISHONESTY AND PLAGIARISM

### **Academic Dishonesty**

- a) Possessing a mobile phone, carrying bits of paper, talking to other students, copying from others during an assessment will be treated as punishable dishonesty
- b) Zero mark to be awarded for the offenders. For copying from another student, both students get the same penalty of zero mark.
- c) The department disciplinary committee constituted with the faculty member, PAC Chairperson, and the HoD, as members shall verify the facts of the malpractice and award the punishment if the student found guilty,

ADDITIONAL COURSE INFORMATION

FOR APPROVAL

OUT-1018
OURSE Faculty

Chairperson (Class Com

Chairperson (Class Committee)

HoD